| U.S. Department of Commerce, Patent and Trademark Office   |                                    |                    |                   | Attorney Docket No.           |                   | Serial                     | Serial No. |  |
|--|------------------------------------|--------------------|-------------------|-------------------------------|-------------------|----------------------------|------------|--|
|  |                                    |                    |                   | DC-03112                      |                   | 10/688                     | 10/688,237 |  |
| INFORMATION DISCLOSURE STATEMENT BY APPLICANT  |                                    |                    |                   | Applicant(s)                  |                   |                            |            |  |
| (Use several sheets if necessary)  |                                    |                    |                   | Munif Farhan Halloush, et al. |                   |                            |            |  |
|  |                                    |                    |                   | Filing Date                   |                   | Group                      | Group      |  |
|  |                                    |                    |                   | October 18, 2003              |                   | 2655                       | 2655       |  |
| U.S. Patent Documents  |                                    |                    |                   |                               |                   |                            |            |  |
| *Examiner  | Document                           | ъ.                 |                   | CI.                           | 0.1.1             | Filing Date If Appropriate |            |  |
| Initial AA   | Number 2003/0021201 A1             | Date Jan. 30, 2003 | Name<br>Kobayashi | Class<br>369                  | Subclass<br>47.39 | If Appro                   | priate     |  |
| AB   | 2003/0021201 A1<br>2003/0058765 A1 |                    | Schreurs et al.   | 369                           | 47.53             |                            |            |  |
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| AD   |                                    |                    |                   |                               |                   |                            |            |  |
| AE   |                                    |                    |                   |                               |                   |                            |            |  |
| AF   |                                    |                    |                   |                               |                   |                            |            |  |
| AG   |                                    |                    |                   |                               |                   |                            |            |  |
| AH   |                                    |                    |                   |                               |                   |                            |            |  |
| AI   |                                    |                    |                   |                               |                   |                            |            |  |
| AJ   |                                    |                    |                   |                               |                   |                            |            |  |
| AK   |                                    |                    |                   |                               |                   |                            |            |  |
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|  | Document                           | Date               | Country           | Class                         | Subclass          | Yes                        | No         |  |
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| AT   |                                    |                    |                   |                               |                   |                            |            |  |
| Examiner Date Considered   |                                    |                    |                   |                               |                   |                            |            |  |
| *EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication to applicant |                                    |                    |                   |                               |                   |                            |            |  |